How reduced vacuum pumping capability in a coating chamber affects the laser damage resistance of HfO$_2$/SiO$_2$ antireflection and high-reflection coatings

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Abstract. Optical coatings with the highest laser damage thresholds rely on clean conditions in the vacuum chamber during the coating deposition process. A low-base pressure in the coating chamber, as well as the ability of the vacuum system to maintain the required pressure during deposition, are important aspects of limiting the amount of defects in an optical coating that could induce laser damage. Our large optics coating chamber at Sandia National Laboratories normally relies on three cryo pumps to maintain low pressures for e-beam coating processes. However, on occasion, one or more of the cryo pumps have been out of commission. In light of this circumstance, we explored how deposition under compromised vacuum conditions resulting from the use of only one or two cryo pumps affects the laser-induced damage thresholds of optical coatings. The coatings of this study consist of HfO$_2$ and SiO$_2$ layer materials and include antireflection coatings for 527 nm at normal incidence and high-reflection coatings for 527 nm at 45-deg angle of incidence in P-polarization.© The Authors. Published by SPIE under a Creative Commons Attribution 3.0 Unported License. Distribution or reproduction of this work in whole or in part requires full attribution of the original publication, including its DOI. [DOI: 10.1117/1.OE.56.1.011005]

Keywords: laser damage; optical coatings; HfO$_2$; SiO$_2$; vacuum; antireflection; high reflection.

Paper 160320SSP received Mar. 4, 2016; accepted for publication Jun. 27, 2016; published online Jul. 15, 2016.

1 Introduction

The large optics coating system at Sandia National Laboratories uses e-beam evaporation to produce optical coatings with high resistance to laser damage for the kJ-class Z-Backlighter laser system. Since 2005, the coating system has been in operation for the production of antireflection (AR), high reflection, polarizer, and dichroic coatings on meter-class optics, using mainly HfO$_2$ and SiO$_2$ coating materials.1,2

Optics with high resistance to laser damage are essential for operating high-power laser systems such as the Z-Backlighter lasers. However, the laser-induced damage threshold (LIDT) of an optical coating is generally lower than the LIDT of the optical substrate material. Laser damage can occur as a result of absorption of energy from the laser by defects in the optical coating or on the substrate. Producing an optical coating with a low number of defects and hence a high LIDT involves many variables, including the substrate preparation,3–10 coating material selections,11 deposition method,11 and the pressures maintained during deposition. Pressure is important because it must be low enough, with a vacuum pumping capability sufficiently high enough, to remove possible gas-phase contaminants from the coating chamber before they can attach to the coating and serve as defects that could increase laser damage. This study concerns pressure, specifically, the consequences of losing some vacuum pumping capability during a coating deposition. This is a concern because, on rare occasions, a vacuum pump requires maintenance and is taken out of service while a coating deposition is in progress. Until this study was conducted, we did not know how the loss of a vacuum pump would impact the LIDT of our coatings. This paper should, therefore, be of strong interest to those involved with the practical aspects of optical coating deposition for high-power laser systems.

The vacuum conditions in our 2.3 m × 2.3 m × 1.8 m coating chamber are maintained by three cryo pumps, which provide base pressures as low as 5e–7 Torr. When a cryo pump goes out of service at some point during a coating deposition, the remainder of the deposition is supported by just two cryo pumps or, in the worst case, one cryo pump. In order to understand how the loss of one or two cryo pumps affects the LIDT of an optical coating, this study replicated those conditions with two of our most common coatings. These coatings are AR coatings for 527 nm at 0-deg angle of incidence (AOI) and high-reflection (HR) coatings for 527 nm at 45-deg AOI, P-polarization (P-pol). In practice, the HR coating is used for fold mirrors, whereas the AR coating is used for transmissive optics (debris shields, vacuum windows, and lenses) for dual wavelengths of 527/1054 nm. We have reported on the LIDT results of the AR coating at 532 and 1064 nm in previous studies.2,4 For this study, the AR and HR coatings were deposited in the coating chamber with one, two, or three cryo pumps in operation. The LIDT of each coating was then measured and analyzed to determine the negative effects of having only one or two cryo pumps in operation.

2 Experimental Method

The AR coatings were a standard four-layer design, and the HR coatings were a 34-layer quarter-wave design, with the final SiO$_2$ layer being a half-wave thick to improve the LIDT.11 The SiO$_2$ layers were produced from the evaporation of SiO$_2$ granules (1 to 3 mm in size) in a rotating dish, with a
Deposition rate of 7 Å/s. The HfO₂ layers were produced by evaporating hafnium metal with an oxygen backfill, resulting in a total pressure in the chamber of 1.1e-6 Torr. The HfO₂ layers were deposited at a rate of 7 Å/s. The HR coatings, the first HfO₂ layer (layer #1) was deposited at a rate of 1 Å/s and the second HfO₂ layer (layer #3) was deposited at a rate of 2 Å/s. In the HR coatings, the HfO₂ layers were deposited at a rate of 3 Å/s. Both the AR and HR coatings were deposited at 200°C. Each coating was deposited onto a 50-mm diameter, 10-mm thick, optically polished fused silica substrate prepared according to our standard cleaning method immediately before being loaded into the coating chamber.

Normally, ion-assisted deposition (IAD) is required to produce thick, multilayer HR coatings without stress problems if the substrate is large and made of fused silica.2 However, because the fused silica substrates in this study are small, we did not take the precaution of producing the HR coatings with IAD. The coating system uses planetary rotation and masking to maintain coating uniformity. Quartz crystal monitoring with a single crystal is used for layer thickness control. Before each coating took place, the base pressure in the coating chamber was near 3e–6 Torr for the AR coatings and 5e–6 Torr for the HR coatings. The pressure in the coating chamber was determined using a calibrated ion gauge (model: 370 Stabil-ion gauge, from Granville Phillips).

A summary of the coating designs and deposition conditions are shown in Table 1.

<table>
<thead>
<tr>
<th>AR coating for 527 nm, 0-deg AOI</th>
<th>HR coating for 527 nm, 45-deg AOI, P-Pol</th>
</tr>
</thead>
<tbody>
<tr>
<td>Four layers → 565.3-nm thick</td>
<td>34 layers—quarter-wave design with outermost layer ~1/2 wave</td>
</tr>
<tr>
<td>SiO₂ deposition rate: 7 Å/s</td>
<td>SiO₂ deposition rate: 7 Å/s</td>
</tr>
<tr>
<td>HfO₂ deposition rate: 1 Å/s</td>
<td>HfO₂ deposition rate: 3 Å/s</td>
</tr>
<tr>
<td>(layer 1), 2 Å/s (layer 3)</td>
<td>(layer 3)</td>
</tr>
<tr>
<td>Deposition time: 46 min</td>
<td>Deposition time: 4 h 53 min</td>
</tr>
<tr>
<td>Base pressure: ~3e–6 Torr</td>
<td>Base pressure: ~5e–6 Torr</td>
</tr>
</tbody>
</table>

4 Results

In this section, we discuss how reducing the number of cryo pumps in operation during the coating depositions affects the following: (1) the spectral characteristics of the coatings, (2) the chamber pressure during depositions, and (3) the LIDT of the coatings.

Transmission spectra of the coatings were taken with a Perkin Elmer Lambda 950 spectrophotometer. The scans were taken 1 month after the coatings were deposited to account for aging effects. The AR coatings, as shown in Fig. 1, are practically identical in transmission no matter how many cryo pumps were in operation during the deposition. We suspect these AR coatings were too thin for slight changes in pressure to result in noticeable spectral differences. On the other hand, the HR coatings’ transmission spectra (Fig. 2) show a slight shift to longer wavelength as the number of cryo pumps in operation decreases. An examination of the pressure in the chamber during deposition helps explain these results.

The total pressure in the chamber during the depositions is shown in Fig. 3 for the AR coatings and in Fig. 4 for the HR...
coatings. Both figures show that fewer cryo pumps lead to higher pressures during SiO₂ deposition, whereas the pressures maintained during the deposition of HfO₂ are more consistent no matter how many cryo pumps were in operation. The pressure results for SiO₂ are not surprising since fewer cryo pumps reduce the pumping speed of particles generated by the deposition, causing higher pressures in the coating chamber.

HfO₂ layers were deposited with O₂ backfill with the back pressure in the chamber managed by a mass flow controller (MKS 250), and it was therefore less apparent at first that fewer cryo pumps cause pressure problems. However, the mass flow controller uses the total pressure in the coating chamber as feedback rather than the actual flow rate of O₂. In other words, the mass flow controller supplies enough O₂ into the chamber so that a certain total pressure is maintained (in this case, 1.1e–4 Torr). This means we had no control over the partial pressure of the O₂ backfill, so it is unclear how much O₂ was actually in the chamber. We have reason to be suspicious because the increased pressures during SiO₂ deposition with fewer cryo pumps seem to indicate a slight excess of particles in the coating chamber that otherwise would not be there if all cryo pumps were in operation. This excess of particles likely also exists during HfO₂ deposition when fewer cryo pumps are in operation, and this could lead to lower O₂ partial pressures due to the total pressure being maintained at a constant value. This would cause poorer oxidation of the Hf coating material and lead to a higher HfO₂ index of refraction. The transmission scans in Fig. 2 indicate that the index of refraction of HfO₂ probably increased because the spectra shift to longer wavelengths, and the HR bandwidths increase slightly as fewer cryo pumps are in operation.

The LIDT results of the AR coatings are shown in Fig. 5. They follow a straightforward trend: as the number of cryo pumps in operation decreases, the LIDT also decreases. All coatings reached their LIDT due to the accumulation of 25 or more NP defects, as shown in the plot in Fig. 6. This confirms the importance of vacuum pumping speed in a coating chamber for producing coatings with the highest resistance to laser damage. The decrease in LIDT is sharpest between the coatings that were produced with three and two cryo
pumps (10.1 and 7.3 J/cm², respectively, or 2.8 J/cm² difference). The difference in LIDT between two and one cryo pumps is just 0.7 J/cm², which is four times less than the LIDT difference between three and two cryo pumps in operation. This indicates that the defects causing laser damage are produced mostly by removing just one cryo pump from service, and removing a second cryo pump does not increase the number of defects much beyond what it already was.

The LIDT results for the HR coatings, presented in Fig. 7, follow a less straightforward trend compared to the AR coatings. Fig. 7 shows that the HR coating on BK7 with three cryo pumps has the highest LIDT. The number of NP damage sites for each HR coating is plotted in Fig. 8, and these data show that the coating deposited with two cryo pumps damaged due to propagation (with an accumulation of 17 NP damage sites), while the coatings deposited with one or three cryo pumps damaged due to the accumulation of 25 or more NP damage sites. Uncharacteristically large numbers of these defect-related, NP damage sites is the reason why one of the two coatings deposited with three cryo pumps had an unusually low LIDT (14 J/cm²), but the source of these defects is probably not related to the deposition or cleaning process; likely there were handling flaws that introduced defects. Fortunately, we deposited the same HR coating several months before on a substrate that was BK7 rather than fused silica but had the same surface quality specifications as the fused silica substrates used in this study. The LIDT results of this coating are included in Figs. 7 and 8 and are closer to what we have previously experienced for this type of coating (i.e., >20 J/cm²). As this coating also reached its LIDT due to the accumulation of NP damage rather than propagating damage, the elimination of defects is of high importance for increasing the LIDTs of these coatings. The NP damage may be caused by particles in the coating chamber that become trapped in the coating, or perhaps they are a result of Hf in the coating that did not get oxidized. Both of these phenomena would be exacerbated by reduced vacuum pumping capability, which slows the pumping speed of particles in the chamber and likely lowers the partial pressure of the O₂ backfill provided during the deposition of HfO₂.

Unlike the AR coatings, the most drastic drop in LIDT for the HR coatings occurs after two cryo pumps are removed from service. In other words, deposition with just one cryo pump results in the fastest accumulation of defect-related laser damage in the HR coatings, producing the lowest LIDT. This again reinforces the importance of adequate
vacuum pumping speed to produce coatings with the highest LIDTs. This difference between the AR and HR coatings is likely related to the electric field intensities in these coatings. In the HR coatings, the electric field intensity is highest in only the few outermost layers and then quenches rapidly within the coating. In the AR coatings, the laser light penetrates through the entire coating, so the electric field intensity does not quench, and this raises the likelihood of illuminating a defect with high intensity fluence compared to HR coatings. In other words, AR coatings are more susceptible to laser damage compared to HR coatings, and we expect defects to play a larger role in influencing the LIDT of AR coatings. However, when conditions are not ideal because of only one cryo pump in operation, it is interesting that the LIDTs of the AR and HR coatings are similar (6.6 and 7.1 J/cm², respectively). We conclude that when vacuum pumping conditions are very poor, neither AR nor HR coatings have an advantage at resisting laser damage.

5 Conclusion
This study addresses whether high LIDT optical coatings for large laser systems can be produced with reduced vacuum pumping capability in a coating chamber. In the case of both AR and HR coatings for 527 nm, reducing the number of cryo pumps in our coating chamber had a negative effect on the LIDT of the coatings, highlighting the importance of adequate vacuum pumping speeds to reduce damage-initiating defects in the coatings.

An increase in the number of NP damage sites at lower fluence is responsible for the reduced LIDTs of coatings deposited with fewer cryo pumps, which is indicative of less-effective oxidation of Hf or the presence of excess particles in the chamber that act as contamination in the coatings. Whether or not the lower LIDT caused by fewer vacuum pumps render an optic unusable depends on the particular application, and we found that the decline in LIDT due to fewer cryo pumps in operation is more drastic for HR coatings (26 J/cm² → 7.1 J/cm²) than AR coatings (10.1 J/cm² → 6.6 J/cm²).

The number of cryo pumps in operation affected the spectral characteristics of our HR coatings. We have evidence that the partial pressure of the O₂ backfill supplied during HfO₂ deposition was reduced due to the presence of excess particles in the chamber caused by lower vacuum pumping speeds. Lower O₂ partial pressure may be less effective at oxidizing Hf, which can increase the index of refraction of the HfO₂ layers and therefore affect the spectral characteristics of the coating. In addition, less-effective oxidation of Hf can lead to lower LIDTs because Hf is highly absorbing. Fortunately, the spectral characteristics of the AR coatings were not affected by reducing the number of cryo pumps, but this is likely because the AR coatings were too thin for slight index of refraction errors to accumulate into noticeable spectral problems.

This study has shown that increasing the vacuum pumping capability in a coating chamber can improve the LIDT of optical coatings by reducing defect-related damage. For us, this means depositing coatings with all three of our cryo pumps in operation. But even under these optimal conditions, the LIDTs were still dominated by NP defects. Therefore, we expect to further improve our LIDTs by determining the source of these defects and learning how to mitigate them.

Acknowledgments
Sandia National Laboratories is a multiprogram laboratory managed and operated by Sandia Corporation, a wholly owned subsidiary of Lockheed Martin Corporation, for the U. S. Department of Energy’s National Nuclear Security Administration under contract AC04-94AL85000.

References

Ella S. Field received her bachelor’s degrees in mechanical engineering and Asian languages and literature from the University of Minnesota in 2009 and her master’s degree in mechanical engineering from Massachusetts Institute of Technology in 2011. She is an engineer at Sandia National Laboratories, Albuquerque, New Mexico USA. She develops optical coatings for the Z-Backlighter Laser and manages operations at the optical support facility.

John Bellum received his BS degree in physics at Georgia Institute of Technology, in 1968 and his PhD in physics at University of Florida, in 1976. He has numerous scientific publications and extensive experience as a physicist and optical engineer. He provides technical leadership for the large optics coating facility at Sandia National Laboratories, specializing in high laser damage threshold optical coatings for large, meter-size optics for petawatt class lasers. He is a senior member of both SPIE and OSA.

Damon E. Kletecka is an optical coating technologist at Sandia National Laboratories in Albuquerque, New Mexico. He has spent the past 12 out of 13 years at Sandia with the large optics coating facility, supporting the general operation and maintenance of the coating system.